

IEEE JOSEPH F. KEITHLEY AWARD IN INSTRUMENTATION & MEASUREMENT
RECIPIENTS

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|--|---|--|
| 2022 | IAN HUNTER
Hatsopoulos Professor in
Thermodynamics, Massachusetts
Institute of Technology,
Cambridge, Massachusetts, USA | "For the development and
commercialization of nonlinear system
identification techniques in instrumentation
and measurement applications." |
| 2021 | ERIC W. STRID
Retired, Board of Directors of
Power Oregon, White Salmon,
Washington, USA | "For contributions to RF microprobing
measurement techniques enabling accurate
on-wafer circuit testing." |
| AND | | |
| K. REED GLEASON
V.P. of Technology Development,
Form Factor, Inc., Livermore,
California, USA | | |
| 2020 | DARIO PETRI
Full Professor, Department of
Industrial Engineering,
University of Trento, Italy | "For contributions to measurement
fundamentals and signal processing
techniques in instrumentation and
measurement." |
| 2019 | ALAN FINKEL
Australia's Chief Scientist,
Canberra City, Australia | "For contributions to high-speed, accurate
measurement of electrical transmission in
the brain and other biological cells." |
| 2018 | DAVID WAYNE ALLAN
President, Allan's Time Interval
Metrology Enterprise, Fountain
Green, Utah, USA | "For leadership in time determination and
precise timing instruments." |
| 2017 | JEROME JOHN BLAIR
Chief Scientist, Keystone
International, Riverside,
California, USA | "For contributions to test procedures for
analog-to-digital and digital-to-analog
converters and to enhanced-accuracy
gamma-ray spectrometry." |
| 2016 | SAMUEL BENZ
Superconducting Electronics
Group Leader and NIST Fellow,
National Institute of Standards
and Technology, Boulder,
Colorado, USA | "For creating and disseminating quantum-
based superconducting voltage standards
that form the basis for worldwide precision
voltage measurements." |
| 2015 | JEAN-CHARLES BOLOMEY
Emeritus Professor, University
Paris Sud, Paris, France | "For pioneering contributions to efficient
modulated probe array technology for fast
electromagnetic near-field techniques and |

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		microwave imagery.”
2014	THOMAS E. LINNENBRINK Manager, Teqovations, LLC, Colorado Springs, Colorado, USA	“For pioneering charge-mode analog-to-digital converters and for developing IEEE-standard converter terminology and test methods.”
2013	DYLAN FORREST WILLIAMS Electrical Engineer, National Institute of Standards and Technology (NIST), Boulder, CO, USA	“For the development of traceable mismatch-corrected microwave-scattering parameters and temporal waveform calibration and measurement.”
2012	RIK PINTELON Professor, Vrije Universiteit Brussel, Brussels, Belgium	“For the development of innovative system identification methods for measurement applications.”
2011	REZA ZOUGHFI Schlumberger Distinguished Prof., Missouri University of Science and Technology Rolla, MO, USA	“For contributions to microwave and millimeter wave measurement techniques for nondestructive testing and evaluation.”
2010	No Award	
2009	BRIAN PETER KIBBLE Retired, National Physical Laboratory Middlesex, United Kingdom	“For pioneering experiments and techniques in the field of fundamental electrical metrology leading to the realization of SI units.”
2008	ROBERT G. FULKS Vice President, GenRad Inc North Chatham, MA USA	“For pioneering developments in automated measurements.”
2007	DOUGLAS KENT RYTTING Rytting Consulting Santa Rosa, CA, USA	“For seminal technical and leadership contributions to microwave network analyzer technology.”
2006	ALESSANDRO M. FERRERO Professor, Politecnico di Milano Departimento di Electtrotecnica, Milano, Italy	“For advancing the measurement of electrical quantities in electric power systems under non-sinusodial conditions.”
2005	CLARK A. HAMILTON President and CEO, Vmetrix, LLC Boulder, CO, USA	“For making the dc Josephson array voltage standard a practical reality.”

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- 2004 HENRY PARSONS HALL “For fundamental contributions to electrical
Retired/Senior Staff Scientist measurements, with particular emphasis on
GenRad, Inc. the development of impedance bridges and
Westford, MA, USA standards, and the application of
 microprocessors to impedance
 measurement science.”
- 2003 NOT AWARDED